

**Notice of References Cited**

Application/Control No.

09/823,437

Applicant(s)/Patent Under  
Reexamination  
PAN ET AL.

Examiner

X L Bautista

Art Unit

2173

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,236,395 B1	05-2001	Sezan et al.	345/723
	B	US-6,342,904 B1	01-2002	Vasudevan et al.	345/723
	C	US-6,678,635 B2	01-2004	Tovinkere et al.	702/179
	D	US-6,144,375	11-2000	Jain et al.	715/500.1
	E	US-6,549,643 B1	04-2003	Toklu et al.	382/107
	F	US-6,418,168 B1	07-2002	Narita, Hideyuki	375/240.16
	G	US-6,055,018	04-2000	Swan, Philip L.	348/448
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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